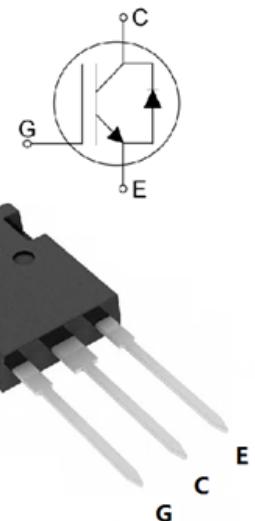


## FEATURES

- High breakdown voltage up to 650V for improved reliability
- Trench-Stop Technology offering :
  - High speed switching
  - High ruggedness, temperature stable
  - Short circuit withstand time – 5μs
  - Low  $V_{CE(sat)}$
  - Easy parallel switching capability due to positive temperature coefficient in  $V_{CE(sat)}$

- Converter with high switching frequency



## APPLICATION

- Uninterruptible Power Supplies
- Inverter
- Welding Converters
- PFC applications

Product	Package	Packaging
HMG75N65FT	TO247	Tube

**Maximum Ratings** ( $T_j = 25^\circ\text{C}$  unless otherwise specified)

$V_{CE}$	<b>650</b>	<b>V</b>
$I_C$	<b>75</b>	<b>A</b>
$V_{CE(SAT)}$ $I_C=75\text{A}$	<b>1.7</b>	<b>V</b>

Parameter	Symbol	Value	Unit
Collector-Emitter Breakdown Voltage	$V_{CE}$	650	V
DC collector current, limited by $T_{jmax}$ $T_C = 25^\circ C$ $T_C = 100^\circ C$	$I_C$	150 75	A
Diode Forward current, limited by $T_{jmax}$ $T_C = 25^\circ C$ $T_C = 100^\circ C$	$I_F$	150 75	A
Continuous Gate-emitter voltage	$V_{GE}$	$\pm 20$	V
Transient Gate-emitter voltage	$V_{GE}$	$\pm 30$	V
Turn off safe operating area $V_{CE} \leq 650V$ , $T_j \leq 150^\circ C$ , $t_p = 1\mu s$	-	225	A
Pulse collector current, $V_{GE} = 15V$ , $t_p$ limited by $T_{jmax}$	$I_{CM}$	225	A
Short Circuit Withstand Time, $V_{GE} = 15V$ , $V_{CE} \leq 400V$	$T_{sc}$	5	$\mu s$
Power dissipation, $T_j = 25^\circ C$	$P_{tot}$	416	W
Operating junction temperature	$T_j$	-40...+150	$^\circ C$
Storage temperature	$T_s$	-55...+150	$^\circ C$
Soldering temperature, wave soldering 1.6mm (0.063in.) from case for 10s	-	260	$^\circ C$

### Thermal Resistance

Parameter	Symbol	Max. Value	Unit
IGBT thermal resistance, junction - case	$R_\theta(j-c)$	0.3	K/W
Diode thermal resistance, junction - case	$R_\theta(j-c)$	0.8	K/W
Thermal resistance, junction - ambient	$R_\theta(j-a)$	40	K/W

**Electrical Characteristics** ( $T_j = 25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
<b>Static</b>						
Collector-Emitter Breakdown Voltage	$\text{BV}_{\text{CES}}$	$V_{\text{GE}}=0\text{V}, I_{\text{C}}=250\mu\text{A}$	650		-	V
		$V_{\text{GE}}=0\text{V}, I_{\text{C}}=1\text{mA}$	650			V
Gate Threshold Voltage	$V_{\text{GE}(\text{th})}$	$V_{\text{GE}}=V_{\text{CE}}, I_{\text{C}}=250\mu\text{A}$	4.6	5.6	6.2	V
Collector-Emitter Saturation Voltage	$V_{\text{CE}(\text{sat})}$	$V_{\text{GE}}=15\text{V}, I_{\text{C}}=75\text{A}$ $T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	-	1.7 2.2	2.2	V V
Zero gate voltage collector current	$I_{\text{CES}}$	$V_{\text{CE}} = 650\text{V}, V_{\text{GE}} = 0\text{V}$ $T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$		0.1	40 5000	$\mu\text{A}$
Gate-emitter leakage current	$I_{\text{GES}}$	$V_{\text{CE}} = 0\text{V}, V_{\text{GE}} = \pm 20\text{V}$			100	nA
Transconductance	$g_{\text{fs}}$	$V_{\text{CE}} = 20\text{V}, I_{\text{C}} = 75\text{A}$	-	40	-	S

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
<b>Dynamic</b>						
Input capacitance	$C_{\text{ies}}$	$V_{\text{CE}} = 25\text{V}, V_{\text{GE}} = 0\text{V},$ $f = 1\text{MHz}$		4500		pF
Output capacitance	$C_{\text{oes}}$			200		
Reverse transfer capacitance	$C_{\text{res}}$			100		
Gate charge	$Q_{\text{G}}$	$V_{\text{CC}} = 480\text{V}, I_{\text{C}} = 75\text{A},$ $V_{\text{GE}} = 15\text{V}$	-	260	-	nC
Short circuit collector current	$I_{\text{C}(\text{SC})}$	$V_{\text{GE}}=15\text{V}, t_{\text{SC}} \leq 5\text{us}$ $V_{\text{CC}}=400\text{V},$ $T_{j, \text{start}}=25^\circ\text{C}$	-	350	-	A

**Switching Characteristic, Inductive Load**

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
<b>Dynamic <math>T_j=25^\circ\text{C}</math></b>						
Turn-on Delay Time	$t_{d(\text{on})}$	$V_{CC} = 400\text{V}, I_C = 75.0\text{A}, V_{GE} = 0.0/15.0\text{V}, R_g = 30\ \Omega$	-	110	-	ns
Rise Time	$t_r$		-	40	-	ns
Turn-off Delay Time	$t_{d(\text{off})}$		-	660	-	ns
Fall Time	$t_f$		-	60	-	ns
Turn-on Energy	$E_{\text{on}}$		-	4.3	-	mJ
Turn-off Energy	$E_{\text{off}}$		-	8.4	-	mJ

**Electrical Characteristics of the DIODE ( $T_j = 25^\circ\text{C}$  unless otherwise specified)**

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
<b>Dynamic</b>						
Diode Forward Voltage	$V_{FM}$	$I_F = 75\text{A}$ , $V_R = 400\text{V}$ , $di/dt = 600\text{A}/\mu\text{s}$	-	2.3	-	V
Reverse Recovery Time	$T_{rr}$		-	75	-	ns
Reverse Recovery Current	$I_{rr}$		-	16	-	A
Reverse Recovery Charge	$Q_{rr}$		-	664	-	nC

Fig. 1 FBSOA characteristics

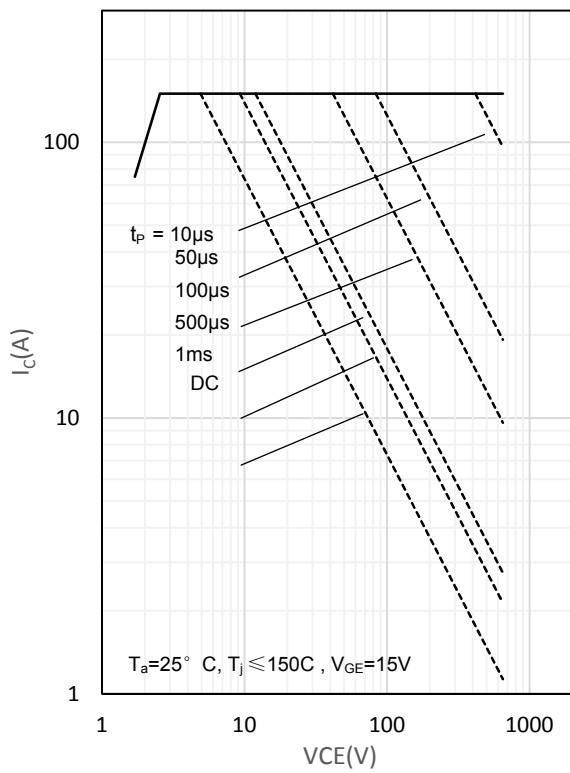


Fig. 2 Power dissipation as a function of  $T_C$

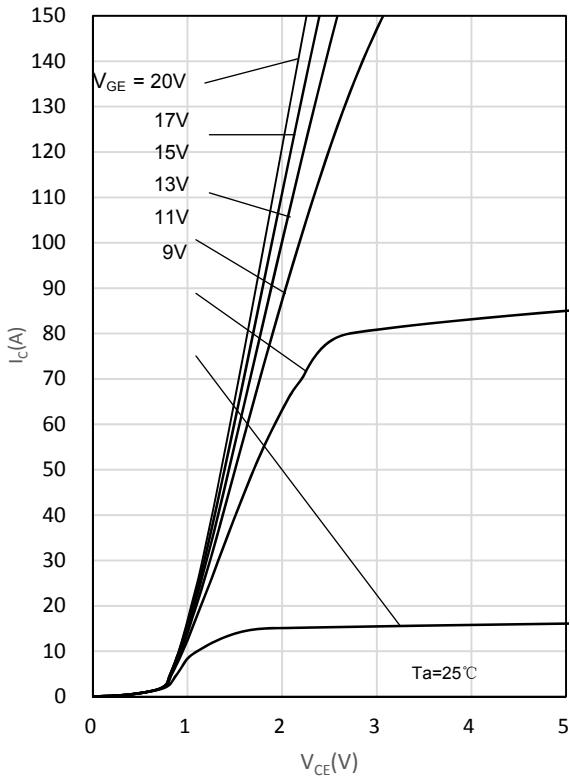


Fig. 3 collector current as a function of  $T_C$

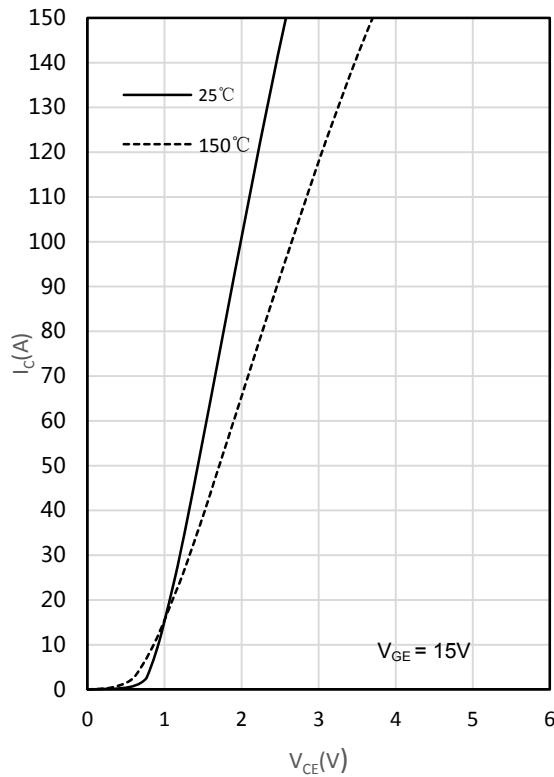


Fig. 4 Switching times vs. gate resistor

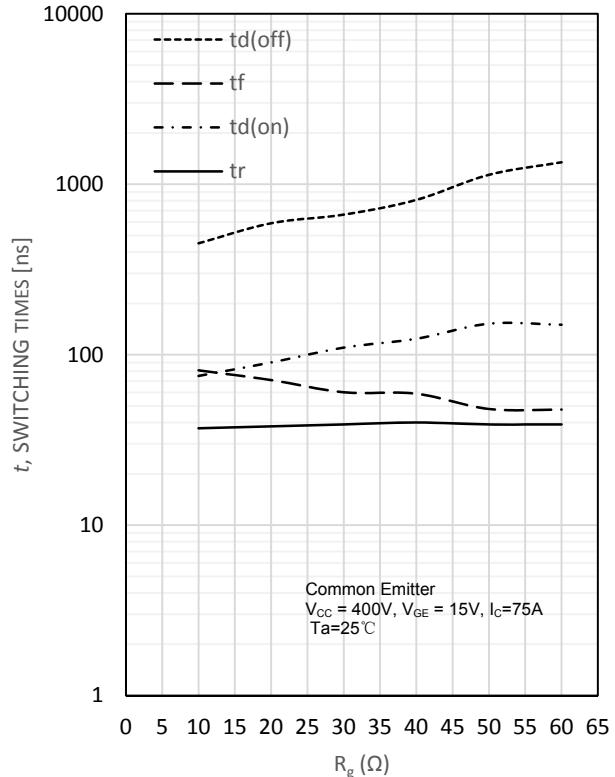


Fig. 5 Switching loss vs. gate resistor

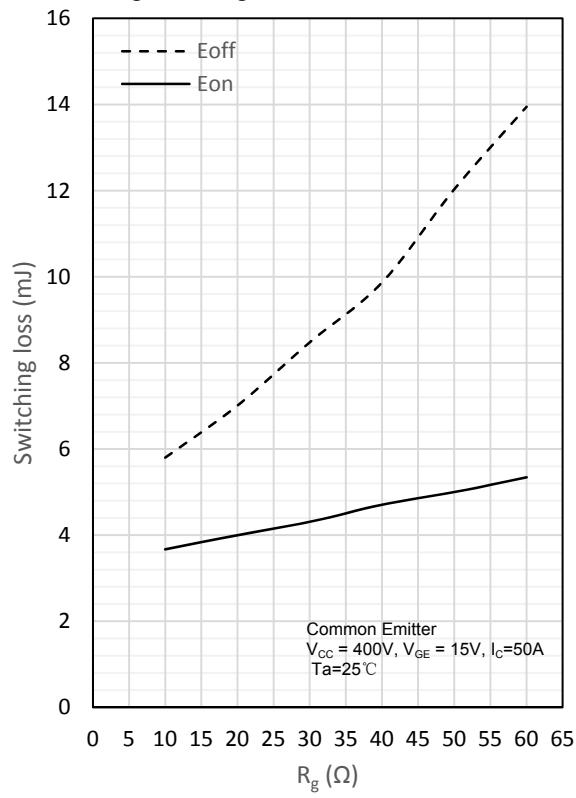


Fig. 6 Gate charge characteristics

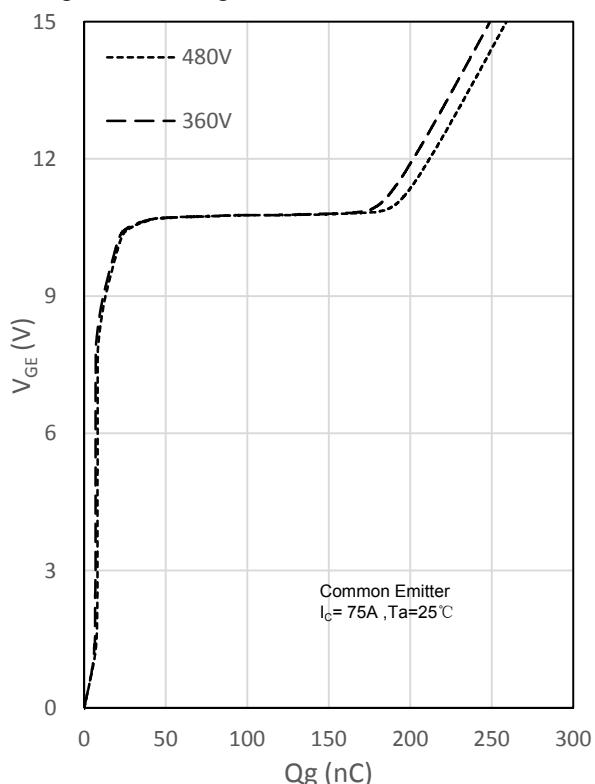
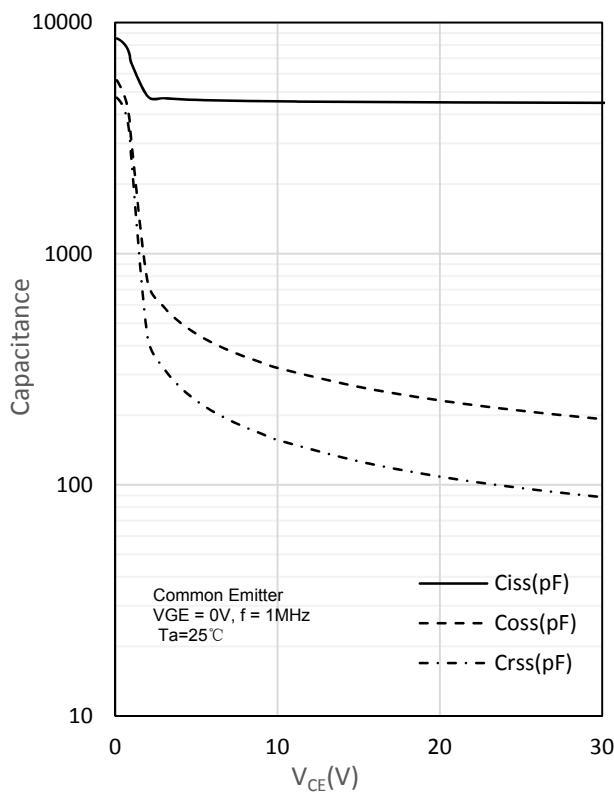
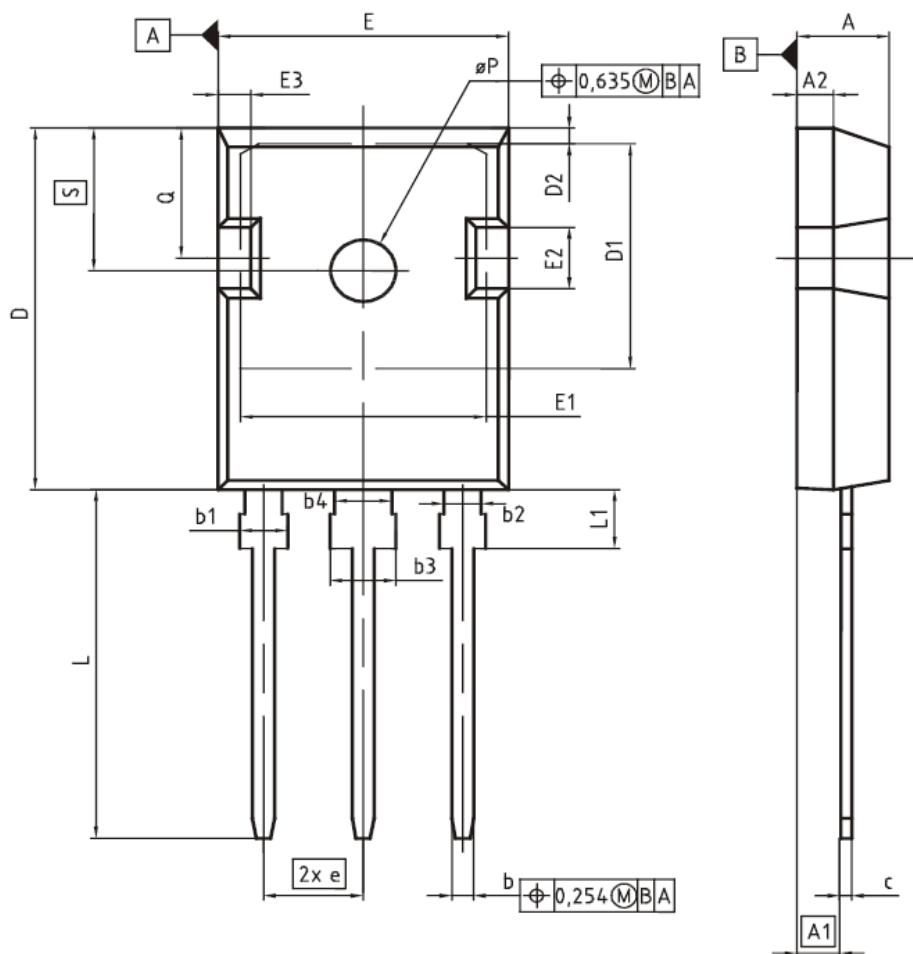


Fig. 7 Capacitance characteristics



PG-T0247-3



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.83	5.21	0.190	0.205
A1	2.27	2.54	0.089	0.100
A2	1.85	2.16	0.073	0.085
b	1.07	1.33	0.042	0.052
b1	1.90	2.41	0.075	0.095
b2	1.90	2.16	0.075	0.085
b3	2.87	3.38	0.113	0.133
b4	2.87	3.13	0.113	0.123
c	0.55	0.68	0.022	0.027
D	20.80	21.10	0.819	0.831
D1	16.25	17.65	0.640	0.695
D2	0.95	1.35	0.037	0.053
E	15.70	16.13	0.618	0.635
E1	13.10	14.15	0.516	0.557
E2	3.68	5.10	0.145	0.201
E3	1.00	2.60	0.039	0.102
e	5.44 (BSC)		0.214 (BSC)	
N	3		3	
L	19.80	20.32	0.780	0.800
L1	4.10	4.47	0.161	0.176
$\phi P$	3.50	3.70	0.138	0.146
Q	5.49	6.00	0.216	0.236
S	6.04	6.30	0.238	0.248